


<b>Search Notes</b>  	<b>Application/Control No.</b>  10510136	<b>Applicant(s)/Patent Under Reexamination</b>  KADOWAKI, YUKIO
	<b>Examiner</b>  Abdelnour, Farras	<b>Art Unit</b>  2624

### SEARCHED

Class	Subclass	Date	Examiner
382	232-253	8/5/2008	ms
375	240-254	8/6/2008	ms
348	384.1-440.1	8/6/2008	ms
358	426.01-426.16	8/6/2008	ms
704	200-230,500-504	8/6/2008	ms
Above	updated	9/30/2008	ms

### SEARCH NOTES

Search Notes	Date	Examiner
Searched IEEE	12/3/2007	FA
image SAME compress\$4 SAME truncat\$4 SAME (quality OR degradat\$4) AND plane	12/3/2007	FA
East Search updated	8/6/2008	ms
Inventor Search	8/6/2008	ms
IDS Search	8/6/2008	ms
East search updated	9/30/2008	ms
Inventor search updated	9/30/2008	ms

### INTERFERENCE SEARCH

Class	Subclass	Date	Examiner

--	--